Search Notes			

Application/Control No	Applicant(s)/Patent un Reexamination	nder
10/757,399	YEH ET AL.	
Examiner	Art Unit	
TUYEN T. NGUYEN	2832	

SEARCHED					
Class	Subclass	Date	Examiner		
336	65, 90-96, 107, 192, 198	3/31/2005	TTN		
123	634-635	3/31/2005	TTN		
ugloted	/	9/15/00	TTW		
			,		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	T- T	F			

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
	į	
	_	